Application No.	Applicant(s)	V.11.
09/974,905	KAMON ET AL.	
Examiner	Art Unit	
Kim-Kwok CHU	2653	
(OR REMAINS) CLOSED ir or other appropriate commu	n this application. If not included unication will be mailed in due co	urse. THIS
<u>3/13/2004</u> .		
2. The allowed claim(s) is/are 2-6, 8, 9, 11 and 12 which are rrenumbered as 1-9 respectively.		
3. The drawings filed on 12 October 2001 are accepted by the Examiner.		
4.		
each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d). 7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
6. ☐ Interview Su Paper No./I 7. ☐ Examiner's A 8. ☑ Examiner's S	mmary (PTO-413), Mail Date Amendment/Comment Statement of Reasons for Allowa	,
	Examiner Kim-Kwok CHU ars on the cover sheet wing (OR REMAINS) CLOSED in correct or other appropriate communication is so and MPEP 1308. At 13/2004. The renumbered as 1-9 respective examiner. The examiner of this communication to file examiner been received in Application examined as the examiner of this application. The examiner of this application. The examiner of this application of the examiner of th	Examiner Kim-Kwok CHU 2653 ars on the cover sheet with the correspondence address (OR REMAINS) CLOSED in this application. If not included or other appropriate communication will be mailed in due co GHTS. This application is subject to withdrawal from issue a and MPEP 1308. W13/2004. renumbered as 1-9 respectively. Examiner. der 35 U.S.C. § 119(a)-(d) or (f). been received. been received in Application No cuments have been received in this national stage application of this application. der 35 U.S.C. § 119(a)-(d) or (f). been received. been received. been received in Application No cuments have been received in this national stage application of this application. der 35 U.S.C. § 119(a)-(d) or (f). been received. been received. been received in Application No cuments have been received in this national stage application of this application. der 35 U.S.C. § 119(a)-(d) or (f). been received. been received. been received. been received in Application No cuments have been received in this national stage application of this application. der 45 U.S.C. § 119(a)-(d) or (f). been received. been rec

Allowable Subject Matter

- 1. Claims 2-6, 8, 9, 11 and 12 are allowable over prior art.
- 2. The following is an Examiner's statement of reasons for the indication of allowable subject matter based on the Amendment filed on August 13, 2004:

As in claims 2, the prior art of record fails to teach or fairly suggest a laser diode for recording data in the recording medium and/or reproducing having the following features:

- (a) the first data include a forward current value of the laser diode;
- (b) the second data include the initial forward current value of the laser diode, and also data indicating the ratio of the forward current value to the initial forward current value for making a decision as to the service life of the laser diode; and
- (c) the data generating means generates, from the first and second data, the third data relative to the service life of the laser diode.

As in claim 3, the prior art of record fails to teach or fairly suggest a laser diode for recording data in the recording medium and/or reproducing having the following features:

(a) the measuring means measures the accumulated emission time of a laser beam from the laser diode;

- (b) the first data include the accumulated laser beam emission time of the laser diode measured by the measuring means;
- (c) the second data include the mean time to failure of the laser diode; and
- (d) the data generating means generates, on the basis of the first and second data, the third data relative to the service life of the laser diode.

As in claim 6, the prior art of record fails to teach or fairly suggest a recording/reproducing apparatus having the following features:

- (a) a second memory means for storing the output value of a temperature sensor obtained at a predetermined temperature, wherein the first data include temperature data; and
- (b) the measuring means measures the temperature by comparing the present output value of the temperature sensor with the prerecorded output value of the temperature sensor obtained at the predetermined temperature and stored in the second memory means.

As in claim 8, the prior art of record fails to teach or fairly suggest a method of detecting the internal state of a recording/reproducing apparatus having the following step:

(a) the first data are measured by accumulating the emission time of the laser beam from the laser diode; and

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(b) the third data are generated by comparing the second data, which represent the service life of the laser diode, with the first data.

As in claim 9, the prior art of record fails to teach or fairly suggest a method of detecting the internal state of a recording/reproducing apparatus having the following step:

- (a) the first data include the result of measuring the forward current of the laser diode;
- (b) the second data include the initial forward current value of the laser diode, and also the rate of the forward current value, which is used for making a decision as to the service life of the laser diode, with the initial forward current value; and
- (c) the third data relative to the service life of the laser diode are generated from the first and second data.

As in claim 11, the prior art of record fails to teach or fairly suggest a method of detecting the internal state of a recording/reproducing apparatus having the following step:

- (a) the first data include data for calculating the forward current value of the laser diode; and
- (b) the second data include the initial forward current value of the laser diode, and also the ratio of the forward current value, which is used for making a decision as to the

service life of the laser diode, with the initial forward current value.

As in claim 12, the prior art of record fails to teach or fairly suggest a recording/reproducing apparatus having the following features:

- (a) the measuring means measures the accumulated emission time of the laser beam from the laser diode; and
- (b) the second data include data indicative of the mean emission time to failure of the laser diode.

The features indicated above, in combination with the other elements of the claims, are not anticipated by, nor made obvious over, the prior art of record.

3. Any comments considered necessary by applicant must be submitted no later than the payment of the Issue Fee and, to avoid processing delays, should preferably accompany the Issue Fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

4. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Kaneko et al. (5,798,992) is pertinent because Kaneko teaches a laser diode monitoring apparatus.

Amada et al. (5,710,787) is pertinent because Amada teaches a laser diode controlling device.

Kenjo (5,029,155) is pertinent because Kenjo teaches a laser
diode monitoring device.

Kobayashi et al. (4,796,250) is pertinent because Kobayashi teaches a laser diode controlling device.

5. Any response to this action should be mailed to:

Commissioner of Patents and Trademarks Washington, D.C. 20231 Or faxed to:

(703) 872-9306 (for formal communications intended for entry. Or:

(703) 746-6909, (for informal or draft communications, please label "PROPOSED" or "DRAFT")

Hand-delivered responses should be brought to Crystal Park II, 2021 Crystal Drive, Arlington. VA., Sixth Floor (Receptionist).

Any inquiry of a general nature or relating to the status of this application should be directed to the Group receptionist whose telephone number is (703) 305-4700.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kim CHU whose telephone number is (703) 305-3032 between 9:30 am to 6:00 pm, Monday to Friday.

Ke 8/3/04

The second secon

Kim-Kwok CHU Examiner AU2653 September 3, 2004

(703) 305-3032

WILLIAM KORZUCH
SUPERVISORY PATENT EXAMINER
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